

	Applica	ition No.	Applicant(s)	
	10/775,	592	PARK ET AL.	
Notice of Allowability	Examin		Art Unit	
,	Kevin W	√vatt	2878	
The MAILING DATE of this communication appeal claims being allowable, PROSECUTION ON THE MERITS IS nerewith (or previously mailed), a Notice of Allowance (PTOL-85) NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT RIP of the Office or upon petition by the applicant. See 37 CFR 1.313	(OR REN or other: IGHTS. T and MPI	MAINS) CLOSED in to appropriate commur Fhis application is su EP 1308.	his application. If not include ication will be mailed in due of	ed course. THIS
. X This communication is responsive to the Amendment after	non-final	l filed 03/15/2007.		
The allowed claim(s) is/are $\underline{1-5,8-12,14-22}$ and 30-38.	• .			•
 Acknowledgment is made of a claim for foreign priority unal All b) Some* c) None of the: 1. Certified copies of the priority documents have 2. Certified copies of the priority documents have 	e been red	ceived.		
3. Copies of the certified copies of the priority documents have		- •		ion from the
International Bureau (PCT Rule 17.2(a)).	Jamoino		Hational stage applicat	ion nom mo
* Certified copies not received:	*	•		
Applicant has THREE MONTHS FROM THE "MAILING DATE" noted below. Failure to timely comply will result in ABANDONM THIS THREE-MONTH PERIOD IS NOT EXTENDABLE. 1. A SUBSTITUTE OATH OR DECLARATION must be subm	MENT of the	his application. The the attached EXAN	MINER'S AMENDMENT or N	
INFORMAL PATENT APPLICATION (PTO-152) which give		•	declaration is deficient.	
5. CORRECTED DRAWINGS (as "replacement sheets") mus				
(a) including changes required by the Notice of Draftspers		ent Drawing Review	(PTO-948) attached	
1) hereto or 2) to Paper No./Mail Date (b) including changes required by the attached Examiner's		mant / Commant ari	n the Office action of	
Paper No./Mail Date	5 Amendi	ment / Comment of t	if the Office action of	
Identifying indicia such as the application number (see 37 CFR 1 each sheet. Replacement sheet(s) should be labeled as such in t				back) of
 DEPOSIT OF and/or INFORMATION about the depo attached Examiner's comment regarding REQUIREMENT 				Note the
Attachment(s)		5 Notice of lafe	ermal Patent Application	
 Notice of References Cited (PTO-892) Notice of Draftperson's Patent Drawing Review (PTO-948) 		6. X Interview Sur		
B. ☐ Information Disclosure Statements (PTO/SB/08),			fail Date .mendment/Comment	
Paper No./Mail Date	••		tatement of Reasons for Allo	

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EXAMINER'S AMENDMENT

1. An examiner's amendment to the record appears below. Should the changes and/or additions be unacceptable to applicant, an amendment may be filed as provided by 37 CFR 1.312. To ensure consideration of such an amendment, it MUST be submitted no later than the payment of the issue fee.

Authorization for this examiner's amendment was given in a telephone interview with Jim Scheller on 04/18/2007.

2. Replace claim 1 with the following:

--A photodetecting array comprising: a plurality of detecting cells laid out in an array on a substrate, comprising rows and columns of detecting cells; a plurality of gate lines, wherein each of the gate lines are coupled to a different row of more than two detecting cells; a plurality of data lines, wherein each of the data lines are coupled to a different column of more than two detecting cells; a mesh of bias voltage lines, comprising a plurality of additional bias voltage lines and a plurality of main bias voltage lines to reduce capacitive coupling, wherein each of the additional bias voltage lines are coupled between at least a pair of main bias lines; wherein each of the main bias voltage lines are coupled to a different row of more than two detecting cells; and wherein the gate lines and main bias voltage lines are laid out in a plurality of rows and the data lines and additional bias voltage lines are laid out in a plurality of columns.--.

Allowable Subject Matter

2. Claims 1-5, 8-12,14-22 and 30-38 are allowed.

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3. The following is an examiner's statement of reasons for allowance:

Regarding claim 1, the prior art fails to disclose or make obvious a photodetecting array comprising, in addition to the other recited features of the claim, "a mesh of bias voltage lines, comprising a plurality of additional bias voltage lines and a plurality of main bias voltage lines to reduce capacitive coupling, wherein each of the additional bias voltage lines are coupled between at least a pair of main bias lines."

Regarding claim 11, the prior art fails to disclose or make obvious a photodetecting device comprising, in addition to the other recited features of the claim, "a mesh of bias voltage lines, comprising additional bias voltage lines and main bias voltage lines, wherein each of the additional bias voltage lines are coupled between at least a pair of main bias voltage lines; wherein the capacitive coupling between the mesh of bias voltage lines and the data lines is substantially limited to the capacitive coupling between the third additional bias voltage line and first data line."

Regarding claims 20 and 22, the prior art fails to disclose or make obvious a photodetecting array or method for manufacturing a photodetecting array comprising, in addition to the other recited limitations or steps of the claim, "wherein each of the additional bias voltage lines are coupled between at least a pair of main bias voltage lines, and wherein the capacitive coupling between the bias voltage lines and the data lines is proportional to the total length of the second additional bias voltage lines."

Regarding claim 38, the prior art fails to disclose or make obvious a photodetecting array comprising, in addition to the other recited features of the claim, "a mesh of bias voltage lines, comprising additional bias lines and main bias lines, wherein

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each of the additional bias lines are coupled between at least a pair of main bias lines; the mesh having a means for limiting the capacitive coupling between the bias voltage lines and the data lines."

Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Kevin Wyatt whose telephone number is (571)-272-5974. The examiner can normally be reached on Monday-Friday.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Georgia Epps can be reached on (571)-272-2328. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free). If you would like assistance from a USPTO Customer Service Representative or access to the automated information system, call 800-786-9199 (IN USA OR CANADA) or 571-272-1000.

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K.W.

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